Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/524,493	GEACH, MARK	
Examiner	Art Unit	
Patricia Leith	1655	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE.	EXMR		
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE	10/21/2007	PL		
Inventor name search PALM/EAST	10/21/2007	PL		
STN: INdexed BIOSCIENCE cluster + Napralert databases (approx. 68 databases total)	10/21/2007	PL		
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE continued	10/22/2007	PL		